Search Notes		

Applicat	ion/Control	No.

Applicant(s)/Patent under Reexamination KATAYAMA ET AL.
Art Unit

10/531,535 Examiner

Hoa Q. Pham

2877

SEARCHED			
Class	Subclass	Date	Examiner
356	2394- 239.8, 240.1	2/1/2007	НР
250	223B	2/1/2007	HP
382	143-145	2/1/2007	HP
			-

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
1			

SEARCH (INCLUDING SEAR	NOTES CH STRATEGY)
	DATE	EXMR
EAST	2/1/2007	НР
copending check	2/1/2007	HP
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